

“Real-Time Reconstruction of Arbitrary Slices for Quantitative and In Situ 3D Characterization of Nanoparticles”. Vanrompay H, Buurlage J?W, Pelt DM, Kumar V, Zhuo X, Liz?Marzán LM, Bals S, Batenburg KJ, *Particle & Particle Systems Characterization* **37**, 2000073 (2020). <http://doi.org/10.1002/ppsc.202000073>